

# Search Notes



Application/Control No.

10/777,206

Examiner

LIEN TM NGO

Applicant(s)/Patent under Reexamination

MARKET ET AL.

Art Unit

3754

## SEARCHED

Class	Subclass	Date	Examiner
222	105 183	2/31/96	mw
	1651		
	424.5		
	210		
220	592.16		
	592.05 - 592.08		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR